Feature Engineering in Machine Learning

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Feature Engineering in Machine Learning

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Outline

- A Machine Learning Primer
 - Machine Learning and Data Science
 - Bias-Variance Phenomenon
 - Regularization
- What is Feature Engineering (FE)?
- Graphical Models and Bayesian Networks
- Deep Learning and FE
- Dimensionality Reduction
- Wrap-up
 - Current Trends
 - Practical Advice on FE

Machine Learning

- Suppose there exists a function y = f(x), now given examples of the form (y,x), can we determine the function f? [1]
 - Functional approximation
 - Input is the Data
 - Roots in Statistics
 - Kin to Data Mining
 - Subset of Data Science
- Countless applications in:
 - Medicine, Science, Finance, Industry, etc.
- Renewed interests due to the emergence of big data
- Part of multi-billion analytics industry of 21st century

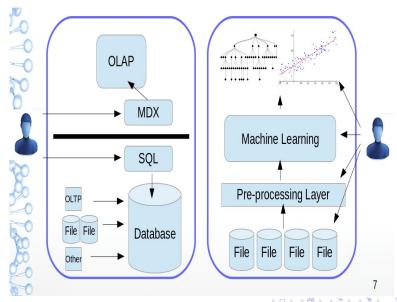
Typical Machine Learning Problems

- Supervised Learning (Classification, Regression)
- Un-supervised Learning (Clustering)
- Recommender Systems
- Market Basket Analysis (Association Rule Discovery)
- Ad-placement
- Link Analysis
- Text Analysis (e.g., mining, retrieval)
- Social Network Analysis
- Natural Language Processing

Applications of Machine Learning



Tale of Two Worlds



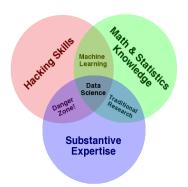
Data Science

- The two worlds are merging into each other day by day
- Database community needs analytics and analytics community needs a way to store and manage large quantities of data
- On-going debate about putting databases into analytics or analytics into databases
- SQL vs. NoSQL
- Database world
 - Pros: Good at storing, accessing and managing large quantities of data
 - Cons: Very bad for analytics (assumes a structure)
- Analytics world
 - Pros:Good at analyzing
 - Cons: Poor at managing data



Data Science

- What constitutes data science:
 - Analytics
 - Storage
 - Visualization
 - Munging



Data-driven World

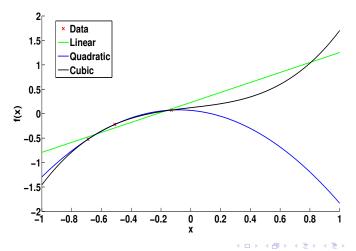
- Four paradigms of science
 - Observational based
 - Experimental based
 - Model based
 - Data based
- "The Fourth Paradigm: Data-Intensive Scientific Discovery", by Jim Gray
- It is not about databases vs. analytics, SQL vs. NoSQL, it is all about data

Fundamental Problem in Machine Learning

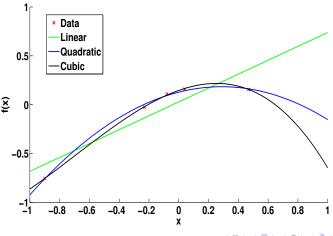
- Regression:
 - $\min_{\beta \in \mathcal{R}^n} \frac{1}{N} \sum_{i=1}^N (y_i \beta^T x)^2 + \lambda \|\beta\|_2^2$
- Classification:
 - $\min_{\beta \in \mathcal{R}^n} \frac{1}{N} \sum_{i=1}^N \mathcal{L}(y_i \beta^T x) + \lambda \|\beta\|_2^2$
- In general:
 - $\min_{\beta \in \mathcal{R}^n} (\text{Loss} + \text{Regularization})$
 - $\min_{\beta \in \mathcal{R}^n} \mathcal{F}(\beta)$
- Important questions:
 - Model selection.
 - Which optimization to use to learn the parameters.
- Different loss functions leads to different classifiers:
 - Logistic Regression
 - Support Vector Classifier
 - Artificial Neural Network



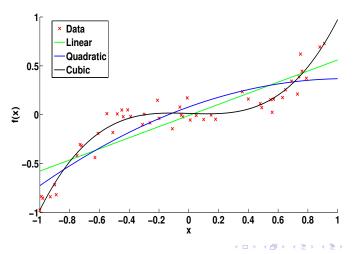
• Let us visit the simplest of all machine learning problem:



• Let us visit the simplest of all machine learning problem:



• Let us visit the simplest of all machine learning problem:



- Observation Models vs. Features
 - You can take the cube of the features and fit a linear model.

•
$$(x_1,\ldots,x_m) \to (x_1^3,x_1^2x_2,x_1x_2x_3,\ldots)$$

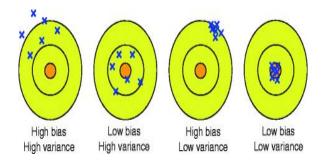
- This will be equivalent to applying cubic model.
- Question Which model should you select? Or equivalently, which attributes interactions should you consider?
- Remember In real world, you will have more than one features - categorical, discrete, etc.
- Hint With every model selection decision there is a control of bias and variance:
 - Why not select model by controlling for both bias and variance?



Parameterizing Model

- How do you handle numeric attributes? One parameter per attribute per class?
- How do you handle categorical attributes? Multiple parameters per attribute per class?
- How do you handle interactions among the variables?
- How do you handle missing values of the attributes?
- How do you handle redundant attributes?
- Over-parameterized model vs. under-parameterized model

Bias Variance Illustration



- Low variance model for small data
- Low bias model for big data
- More details in [2]
- Machine learning has been applied on small quantities of data
 - Here, low variance algorithms are the best
 - Low bias algorithms will over-fit and you need to rely on regularization or feature selection
- Feature Selection
 - Forward selection
 - Backward elimination

Regularizing your Model

- Very powerful technique for controlling bias and variance
- Many different regularizations exists, most common:
 - L2 Regularization

•
$$\min_{\beta \in \mathcal{R}^n} \frac{1}{N} \sum_{i=1}^N \mathcal{L}(y_i \beta^T x) + \lambda ||\beta||_2^2$$

- L1 Regularization (also know as sparsity inducing norms)
 - $\min_{\beta \in \mathcal{R}^n} \frac{1}{N} \sum_{i=1}^N \mathcal{L}(y_i \beta^T x) + \lambda \|\beta\|_1$
- Or elastic nets
 - $\min_{\beta \in \mathcal{R}^n} \frac{1}{N} \sum_{i=1}^N \mathcal{L}(y_i \beta^T x) + \lambda(\|\beta\|_1 + \gamma \|\beta\|_2^2)$

Feature Engineering

- Feature engineering is the process of using domain knowledge of the data to create features that make machine learning algorithms work.
- It is fundamental to the application of machine learning, and is both difficult and expensive.
- The need of manual feature engineering can be obviated by automated feature learning.
 - Wikipedia
- Coming up with features is difficult, time-consuming, requires expert knowledge. Applied machine learning is basically feature engineering.
 - Andrew Ng
- Is this what feature engineering is?



Feature Engineering (Contd)

- Feature Engineering is the next buzz word after big data.
- But. On the basis of Wikipedia definition, one can say that feature engineering has been going on for decades.
 - Why so much attention now?
- In my view Feature Engineering and Big Data are related concepts.
- For big data, you need big models
 - Big models Any model with very large no. of parameters.
 - Note that a big model can be simply linear.
- For big models, it is more of an engineering problem as to how handle these parameters effectively.
 - Since the hardware has not scaled-up well with data.



Feature Engineering (Contd)

- Given a model, learning problem is the learning of the parameters of model.
- The number of parameters depends on the number of features that you have:
 - Exception, if you are solving for the dual.
 - There will be some hyper-parameters.
- Parameter estimation is done by optimizing some objective function.
- Traditionally, there has been four elements of interest:
 - Features
 - Model
 - Objective function
 - Optimization



Feature Engineering (Contd)

- Models and features are related.
 - Let us not worry about that for the time being.
- There have been two main objective functions that is:
 - Conditional Log-Likelihood P(y|x).
 - Log-Likelihood P(y, x).
- This distinction has led to generative-discriminative paradigms in machine learning.
 - Generative models P(y, x).
 - Discriminative models P(y|x).
 - Very confusing distinction with no obvious benefits.

Generative vs. Discriminative Models/Learning

- Bayes rule: $P(y|x) \propto P(y,x)$
- Converting \propto to =, we get: $P(y|x) = \frac{P(y,x)}{P(x)}$.
- And therefore, $P(y|x) = \frac{P(y,x)}{\sum_{c} P(c,x)}$.

Generative vs. Discriminative Models/Learning

A well-known generative model – Naive Bayes

$$P(y|x) = \frac{\pi_y \prod_i P(x_i|y)}{\sum_c \pi_c \prod_i P(x_i|c)}$$
(1)

• A well-known discriminative model - Logistic Regression

$$P(y|x) = \frac{\exp(\beta_y + \sum_i \beta_{i,x_i,y} x_i)}{\sum_c \exp(\beta_c + \sum_i \beta_{i,x_i,c} x_i)}$$
(2)

On the Equivalence of Generative vs. Discriminative Models/Learning

• We have naive Bayes as:

$$P(y|x) = \exp(\log \pi_y + \sum_i \log P(x_i|y) - \log(\sum_c \pi_c \prod_i P(x_i|c)))$$

Same exp and log trick:

$$P(y|x) = \exp(\log \pi_y + \sum_i \log P(x_i|y) - \log(\sum_c \exp(\log \pi_c + \sum_i \log P(x_i|c))))$$

$$\log P(y|x) = \log \pi_y + \sum_i \log P(x_i|y) - \log(\sum_c \exp(\log \pi_c + \sum_i \log P(x_i|c))).$$

On the Equivalence of Generative vs. Discriminative Models/Learning

- Now, let us take the log of LR: $\log P(y|x) = \beta_y + \sum_i \beta_{i,x_i,y} x_i \log(\sum_c \exp(\beta_c + \sum_i \beta_{i,x_i,c} x_i))$
- Reminder, for NB we had:

$$\log P(y|x) = \log \pi_y + \sum_i \log P(x_i|y) - \log(\sum_c \exp(\log \pi_c + \sum_i \log P(x_i|c))).$$

• NB and LR are just re-parameterization of each other for example: $\beta_y = \log \pi_y$ and $\beta_{i,x_i,y} = \log P(x_i|y)$.



On the Equivalence of Generative vs. Discriminative Models/Learning

Modifying NB:

$$\log P(y|x) = w_y \log \pi_y + \sum_i w_{x_i|y} \log P(x_i|y) - \log(\sum_c \exp(w_c \log \pi_c + \sum_i w_{x_i|c} \log P(x_i|c))).$$

This leads to:

$$P(y|x) = \frac{\pi_y^{w_y} \prod_i P(x_i|y)^{w_{x_i|y}}}{\sum_c \pi_c^{w_c} \prod_i P(x_i|c)^{w_{x_i|c}}}$$

- NB and LR are just re-parameterization of each other, so why the fuss?
- More details in [3, 4, 5]



Summary so far

- Model selection and feature selection are tightly coupled.
 - Feature Engineering
- The distinction between CLL and LL is confusing. Rather, superfluous.
- They only differ in the way parameters are being learned:
 - For LL (naive Bayes), parameters are empirical estimates of probability
 - For CLL (LR), parameters are learned by iterative optimization of some soft-max.
- This leaves two things:
 - How to do feature engineering?
 - How to actually optimize?



How to Engineer Features?

- Regularization
- Use domain knowledge
- Exploit existing structure in the data
- Dimensionality reduction
- Use data to build features

Domain Knowledge

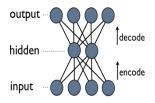
- Use of expert knowledge or your knowledge about the problem
- Use of other datasets to explain your data
- Main advantage is the simplicity and intuitiveness
- Only applies to small number of features
- Access to domain expert might be difficult
- Summary You use some information at your disposal to build features before starting a learning process

Dimensionality Reduction

- Feature Selection
 - Filter
 - Wrapper
 - Embedded
- Principle Component Analysis (PCA)
- Linear Discriminant Analysis (LDA)
- Metric Learning [6, 7]
- Auto-encoders

Auto-Encoders

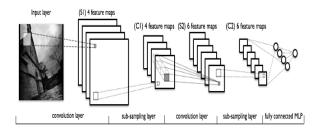
- Similar to multi-layer Perceptron
- Output layer has equally many nodes as input layer
- Trained to reconstruct its own input
- Learning algorithm: Feed-forward back propagation
- Structure:



Exploit Structures in the Data

- Some datasets have an inherent structure, e.g., in computer vision, NLP
 - You can use this information to build features
- Convolutional Neural Networks
 - CNNs exploit spatially-local correlation by enforcing a local connectivity pattern between neurons of adjacent layers
 - Feed-forward neural network
 - Very successful in digit and object recognition (e.g., MNIST, CIFAR, etc.)

Convolutional Neural Networks



Use Data to Build Features

- Restricted Boltzmann Machines
 - Trained by contrastive divergence
- Deep Belief Networks
- Many more variants

Lessons Learned from Big Data

- Automatic feature engineering helps
- Capturing higher-order interactions in the data is beneficial
- Low-bias algorithms with some regularization on big data leads to state-of-the-art results
- If you know the structure, leverage it to build (engineer) features
- What if you don't know the structure
 - Use heuristics

Optimization

• Let us focus on the optimization:

$$w_{t+1} = w_t - \eta \frac{\partial OF(w)}{\partial w}$$
 (3)

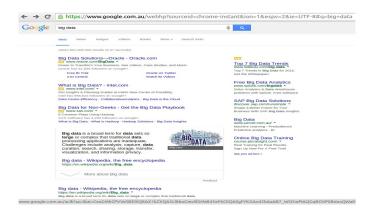
Going second-order:

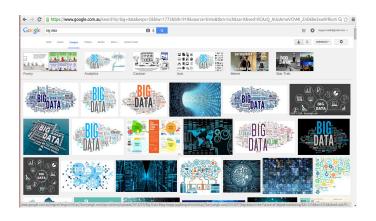
$$w_{t+1} = w_t - \eta \frac{\partial^2 OF(w)}{\partial w}$$
 (4)

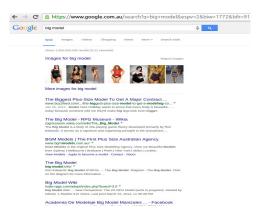
Place regularization to make function smooth for second-order differentiation

Implementation issues in Optimization

- Can we leverage map-reduce paramdigm? No
- Massive Parallelization is required to handle parameters
- Batch version you can distribute parameters across nodes
- SGD you can rely on mini-batches
- Success in deep learning is attributed to advancements in optimization and implementation techniques







- Big Data:
 - Lot of hype around it
 - Volume, Velocity, Variety, Varsity
 - Lots of efforts for managing big data
- Big Models:
 - Models that can learn from big data
 - For example: [8, 9]
 - Deep and Broad
 - Ingredients: Feature Engineering + Stable Optimization
- It is the big models that hold key to a break-through than big data.

Conclusion and Take-away-home Message

- Two most important things: Feature Engineering + Optimization
- Big Model not big data
- Big Model: Low bias + Out-of-core + Minimal tuning parameters + Multi-class
- Big Model: Deep + Broad
- Questions

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